

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,924	BAUM ET AL.	
Examiner	Art Unit	
Benjamin Kurtz	1723	

	SEAR	CHED	
Class	Subclass	Date	Examiner
210	85, 87, 93 96.1, 101, 198.1	1/31/2006	вк
210	199, 259	1/31/2006	вк
210	205, 219	1/31/2006	вк
210	754, 759	1/31/2006	вк
210	163, 164	1/31/2006	вк
210	143	1/31/2006	вк
422	28, 37	1/31/2006	BK
422	105, 62	1/31/2006	вк
422	108, 110	1/31/2006	вк
422	111	1/31/2006	вк
137	88	1/31/2006	вк
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
1	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
•	DATE	EXMR		
Joe Drodge	1/31/2006	вк		
Terry Cecil	1/31/2006	ВК		
John Kim	1/31/2006	вк		